

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/623,860	TOBITA ET AL.
	<b>Examiner</b> Shean C. Wu	<b>Art Unit</b> 1756

**SEARCHED**

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
252	299.01	7/12/2006	SW
	299.5		
257	E23.107		
524/495; 428/1.1, 32.63,35.7,297.4,299.1			